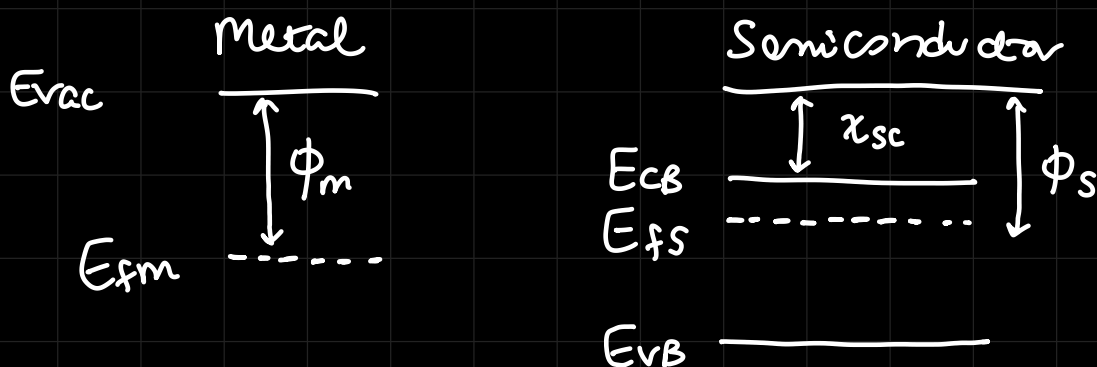


Ideal MS contact

- no oxide layer between the metal & the semiconductor (no gap)
- no inter mixing and no inter diffusion between the metal and the semiconductor
- no impurities at the MS interface

Individually, M and S are at equilibrium but as a single system (junction), it is at non equilibrium state because there are 2 E_f levels.



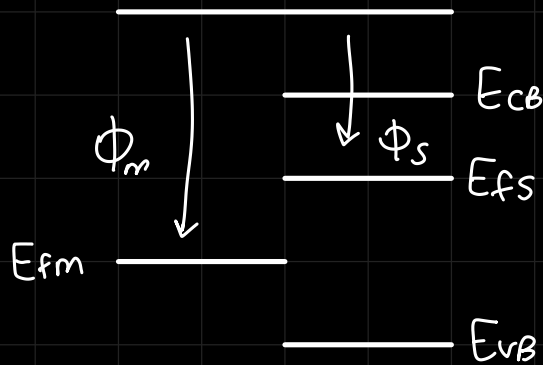
for equilibrium → $E_{fm} = E_{fs}$
↳ tries to attain lowest energy level if not at equilibrium

either $E_{fm} \uparrow$ OR $E_{fs} \downarrow$ or simultaneously

metals have e^- and hence taking out e^- will not make much diff in E_{fm}

but for semiconductors E_{fs} can easily move

So, we assume E_{fm} as static and E_{fs} moves \downarrow

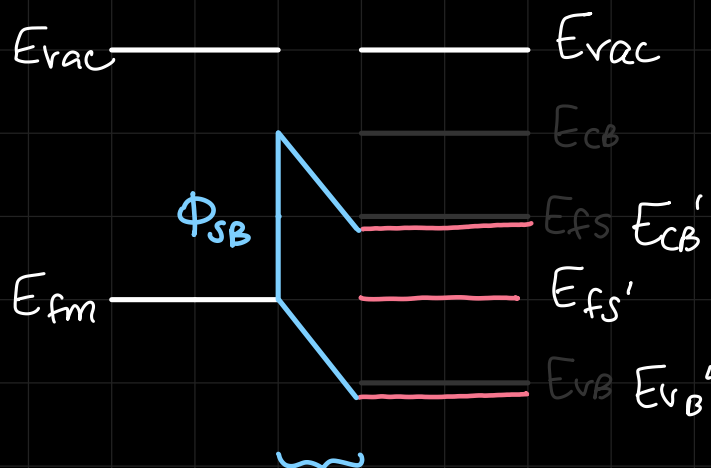


assuming n type semiconductor so,

$$\phi_m > \phi_s$$

E_g, χ_e

if we want E_{fs} to go down, E_{cb}, E_{vb} , and even intrinsic fermi level should also go down that much so that the properties of the semiconductor remains the same.



We need to
remove e^- from SC
to make E_f go \downarrow

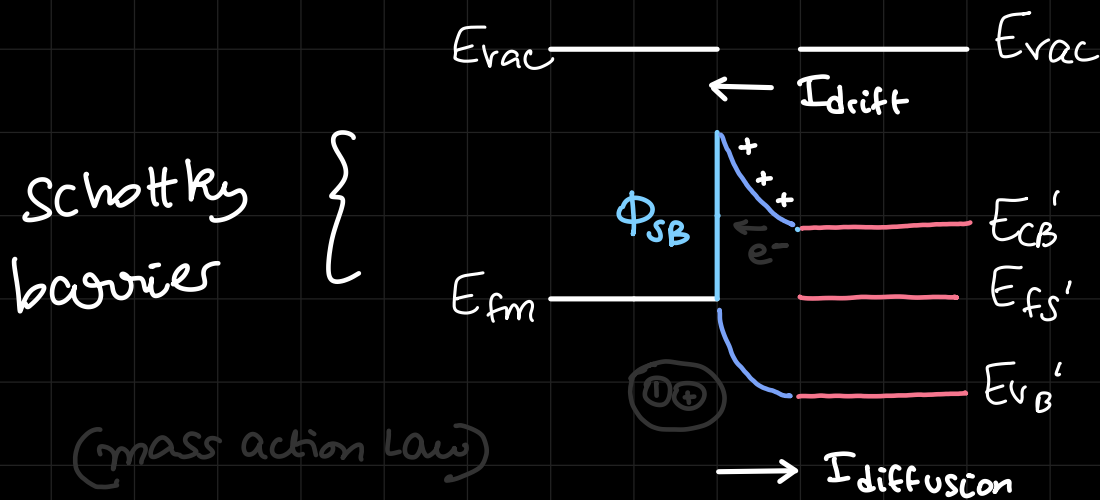
Junction

and those e^- move from SC to e^- until equilibrium is reached

- e^- from Semiconductor side diffuse to the metal side
- ↳ static ions appear
- ↳ band bending takes place

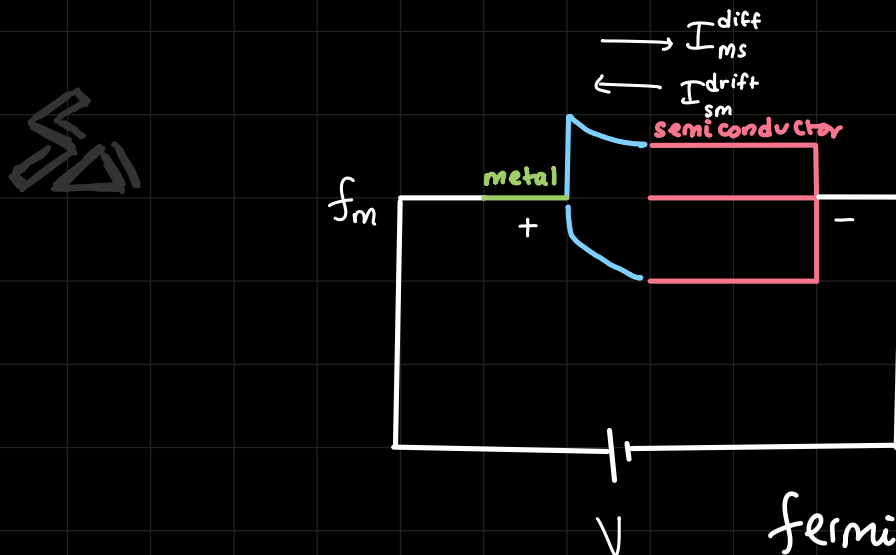
diffusion current is generated from $SC \rightarrow M$
(opposite to flow of e^-)

drift current generated from $M \rightarrow S$



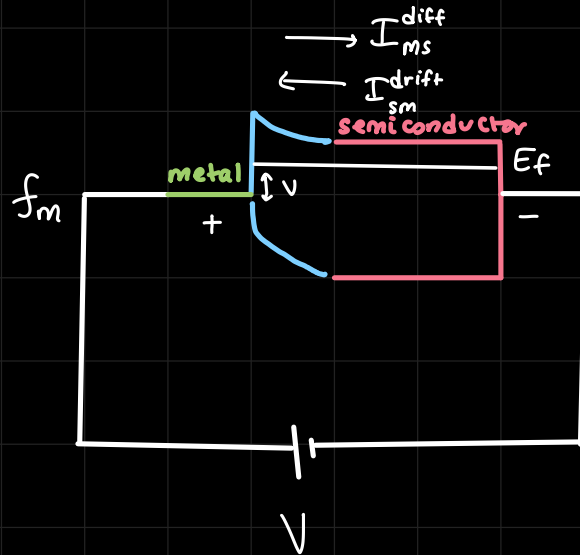
$M \rightarrow S$

to maintain equilibrium,
holes are being generated
at the E_{vb} side



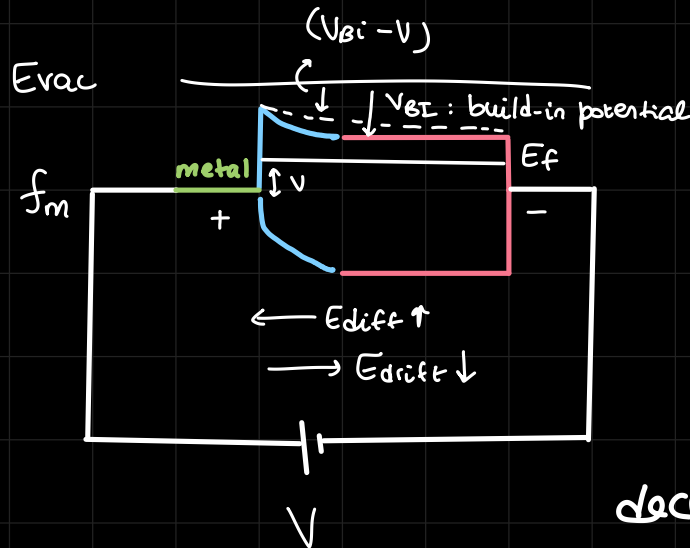
fermi level shifts due to this
chemical potential

$$f(E) = \frac{1}{1 + e^{(E - E_f)/k_B T}}$$



→ non equilibrium state

So other properties must change as well like the band bending



$$\bar{E} = \frac{dE_c(k)}{dk}$$

\bar{E} is defined by the band bending and since the bending

decreases when we

Apply a potential

bias, and hence

$I_{drift} \downarrow$ and since

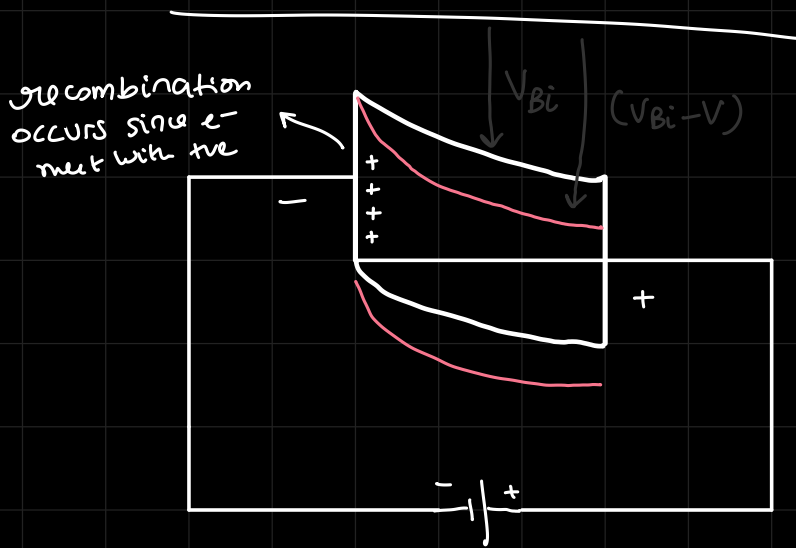
the barrier height \downarrow ,

e^- faces less barrier

and hence diffusion

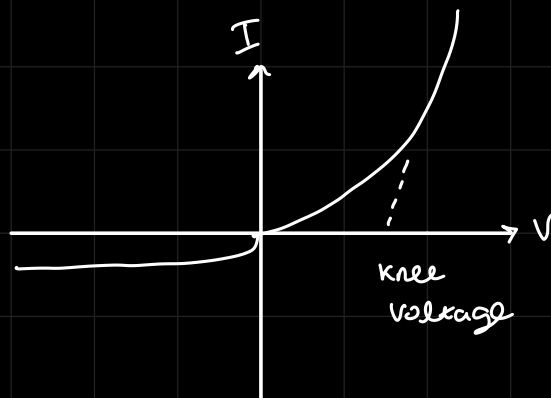
current \uparrow .

Reverse Bias Potential



Reverse bias: intuitively $f_n \uparrow$ but it is ez to see $f_{sc} \downarrow$ rather than $f_n \uparrow$ and hence band bending \uparrow

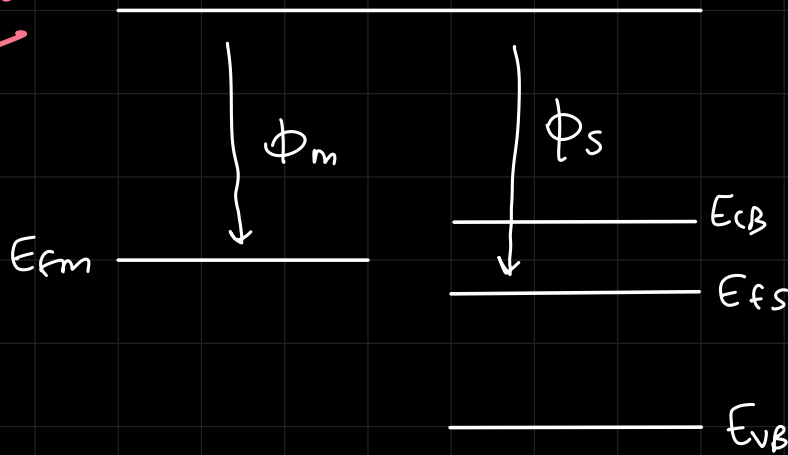
$I_{diffusion}$: negligible



Schottky
barrier

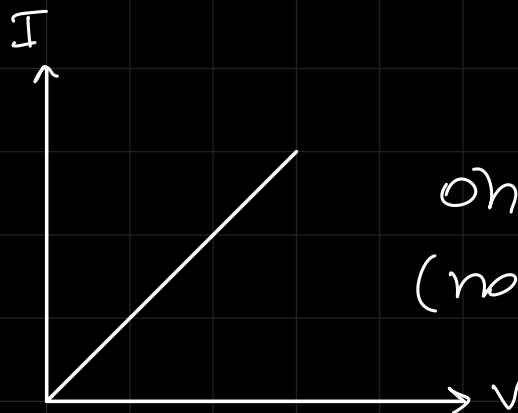
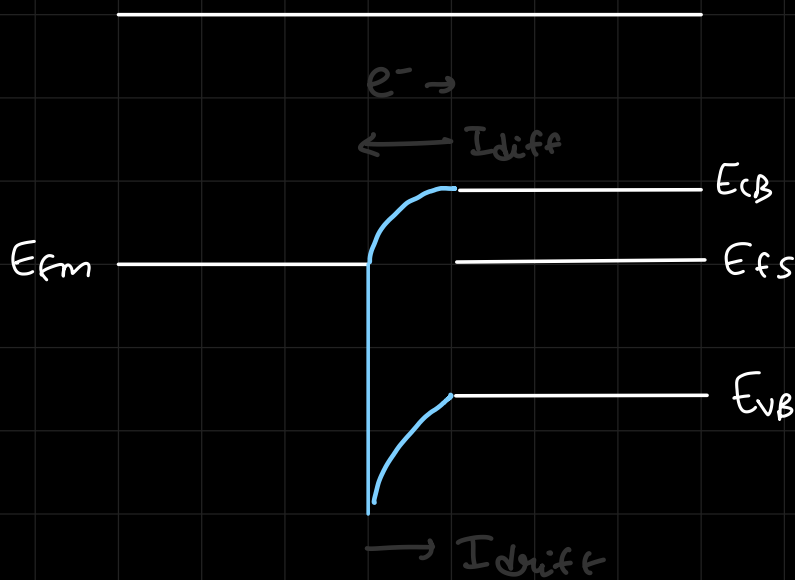
A PN Junction
has a similar
IV characteristic
graph but a higher
knee voltage

$$\phi_m < \phi_s$$



now E_{fs} should go up \uparrow
needs e^-

so, e^- travels from $m \rightarrow s$



ohmic
(non rectifying)

$\phi_m < \phi_s \rightarrow \text{Ohmic}$

$\phi_m = \phi_s \rightarrow \text{Ohmic} \quad (\sim 0 \text{ drift current})$

$\phi_m > \phi_s \rightarrow \text{Schottky}$

We have taken lightly doped n type
semiconductor